

APPROVAL SHEET

WLPM252012 Series SMD Molded Power Inductors

*Contents in this sheet are subject to change without prior notice.



Features

- 1. Shielded construction.
- 2. Ultra low buzz noise.
- 3. Low DCR/µH.
- 4. Handles high transient current spikes without saturation.
- 5. Encapsulated body offers improved environmental protection and moisture resistance.
- 6. Higher dielectric withstanding voltage.
- 7. Corrosion resistant package.
- 8. RoHS Compliance.

Applications

- 1. PDA/Notebook/Desktop/Server applications high current and low profile power supplier.
- 2. High current POL converters.
- 3. Battery powered devices.

Shape and Dimension





Code	Dimensions(mm)
L	2.5 ± 0.2
W	2.0 ± 0.2
Т	1.2 MAX.
е	0.5 ±0.3

Recommend Pattern



(Unit: mm)



Ordering Information

WL	РМ	2520	12	М	R33	Р	В
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	SMD molded power inductor.	2.5 * 2.0mm	1.2mm	M: ± 20%	R33=0.33uH 2R2=2.20uH	P=7" Reeled (Embossed tape)	B:STD

Electrical Characteristics

WLPM252012 series

Walsin Part Number	L(uH)	Tolerance	Measuring Frequency (MHz),1V	RDC Maximum (Ω)	Rated ((mA) (Current MAX.)
				(MAX.)	ldc 1	ldc 2
WLPM252012MR47PB	0.47	М	2	0.039	4000	3400
WLPM252012MR68PB	0.68	М	2	0.048	3000	3000
WLPM252012M1R0PB	1.00	М	2	0.059	2700	2700
WLPM252012M1R5PB	1.50	М	2	0.072	2600	2400
WLPM252012M2R2PB	2.20	М	2	0.117	1900	1900
WLPM252012M3R3PB	3.30	М	2	0.156	1600	1700
WLPM252012M4R7PB	4.70	М	2	0.260	1300	1300

Maximum rated voltage: DC25V

*)The saturation current value (Idc1) is the maximum DC current value having inductance decrease down to 30% (at 20 deg C)

*)The temperature rise current value (Idc2) is the maximum DC current value having temperature increase up to 40degC. (at 20 deg C) *)The rated current is following either Idc1 or Idc2. which is the lower one.

%Caution for Temperature Rise.

Temperature rise of this inductor depends on the installed board condition. It shall be confirmed in the actual end product that. temperature rise of inductor is within operating temperature.

%Operating temperature:-40 $^\circ\!\!\!\mathrm{C}\,{\sim}105\,^\circ\!\!\!\mathrm{C}$

 $Storage temperature:-40^{\circ}C \sim +85^{\circ}C$



Electrical Properties

DC Current Characteristics



L VS Frequency Current Characteristics









	Indu	ctance(uH)	WLPM2	52012M2R2P	B L VS FREQ	UENCE	
2.1 2 1.9 1.8 1.7 1.7 1.6							
0.0	001 0	.1 1.	0 1 Frequer	.5 2. ncy(MHz)	0 2	.5 3.	0

Reliability Testing

	Test Item	Standard	Test method
RISTICS	Resistance to flexure substrate	No damage.	The test samples shall be soldered to the testing board and by reflow soldering conditions as show in page5 (Reflow profile chart). Apply pressure in the direction of the arrow until bent width reaches 2 mm. Pressure 10 20 Pressure 10 20 Rod Rod Rod Rod Rod Rod Rod Substrate size:100*40*1.0 Substrate material:glass epoxy-resin Solder cream thickness :0.12 (Land size refer to recommended Land Pattern
CTE	A 11		Dimensions of "Precaution:)
MECHANICAL CHARA(Adhesion of Terminal electrode	No abnormality.	The test samples shall be soldered to the testing board and by reflow soldering conditions as shown page5 (Reflow profile chart).
	Body strength	No damage.	Applied force :10 N Duration :10 s R0.5 mm Sample

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	Resistance to vibration	Inductance change: Within±10% No abnormality	The test samples shall be soldered to testing jig as shown in under table.						
		observed in	Frequ	ency range 1	10~55Hz				
		appearance.	Overall Amplitude 1.5mm(Shall not exceed acceleration 196 m/S ²)						
			Sweep	oing Method 1	10 to 55 to	10 Hz for 1 n	nin.		
				Time 2	2 hours ead	ch in X,Y, and	d Z directio	n.	
	Resistance to Soldering	Inductance change: Within±10% No abnormality observed in appearance.	3 time o with pea Substra Substra	of reflow oven ak temperature te thickness. te material:gla	at 230 deg e at 260+0 1.0mm ass epoxy-	IC min for 40 /-5 degC for s resin	sec max. 5 sec max.		
	Solderability	At least 90% of surface of terminal electrode is covered by new solder.	The test under ta Flux: me { Pb free	t samples sha able. ethanol solutic e solder: Sn-3	ull be subm on with 25% Ag-0.5Cu}	erged molten % of rosin or e	solder as	shown in	
			Solde	r Temperature	245	±5 deg C			
				Time	5	5±0.5s.			
			Immersing Speed 25		5 mm/s				
			{Eutectic solder}						
					230		_		
			100,000			0±0.5S.			
	Temperature	Inductance change:	Moocur	ersing Speed		o tomporatur	range of	40 dogC to	
	characteristics	Within±15% No abnormality. observed in appearance.	+85 deç value.	gC and the val	lue at +20	degC was us	ed as the s	standard	
	Thermal shock	Inductance change: Within±10% No abnormality observed in appearance.	The test solderin The test tempera sequent The tem <u>Condition</u>	t samples sha og conditions a t samples sha ature in steps ce. operature cyclo ons for 1 cycle	Il be solde as shown ir Il be left fo from 1 to 4 es shall be a.	red to the tes n page5 (Refl r the specifie , as shown ir repeated 10	ting jig and ow profile d time at e n under tab 0 cycled in	d by reflow chart). ach of le in the Method.	
			Step	Tempera	ature	Time(n	nin)		
			1	-40±3 de	eg C	30±	3		
			2	Room T	emp	Withir	n 3		
			3	85±2 de	eg C	30±	3		
	Low		4	Room T	emp	Withir	13		
	Low temperature life test	inductance change: Within±10% No abnormality observed in appearance	And after	t samples sha ig conditions a er that proceed	as shown in d the test a -40+4	red to the tes n page5 (Refl as shown con 2 deg C	ow profile dition unde	chart). er table.	
			101	Time	1000	0+24 h			

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	Hihg temperature life test	Inductance change: Within±10% No abnormality	The test samples shall be soldered to the testing jig and by reflow soldering conditions as shown in page5 (Reflow profile chart). And after that proceed the test as shown condition under table.				
		observed in appearance.	Tempe	rature -40±2	deg C		
			Tin	ne 500-	⊦24h		
ESTS	Damp heat life test	Inductance change: Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the testing jig and by reflow soldering conditions as shown in page5 (Reflow profile chart). The test samples shall be put in thermostatic oven set at temperature with humidity as shown in under table.				
T TE				Temperature	erature 60±2 deg		
ΛEN ⁻				Humidity	90~95%	RH	
NNC				Time	500+24	n	
Loading under damp heat life test				mples shall be solder onditions as shown in mples shall be put in e with humidity, as sh nt continuously applie Temperature Humidity Applied current	ed to the tes page5 (Refi hermostatic own in unde d. 60±2 deg 90~95% Refer to	ting jig and by low profile cha oven set at r table and wi g C RH Page 3	y reflow art). th the
				Time	500+24	n	ĺ

Standard measuring condition	Unless otherwise specified, at least 2 hrs of recovery under the room temperature and normal humidity after the test. followed by the measurement within 48 hrs
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Reflow Profile Chart (Reference):



The products may be exposed to reflow soldering process of above profile up to two times.



Tape & Reel Packaging Dimensions

Dimensions



A ₀	Bo	W	F	E	P1	P ₂	P ₀	Do	Т	K
2.30 ±0.10	2.80 ±0.10	8.00 ±0.20	3.50 ±0.05	1.75 ±0.10	4.00 ±0.10	2.00 ±0.05	4.00 ±0.10	Φ1.5 +0.10 -0	0.30 ±0.05	1.45 max

Direction of rolling





Reel



Label position : the opposite side of pilot holes

Top tape strength



Peel-off strength: 0.1N~1.2N Peel-off angle:165°~180° Peel-off speed: 300mm/min

Quantity per reel: 3K pcs